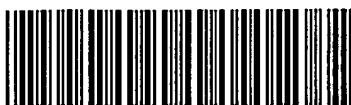


Search Notes

Application/Control No.

10/656,223

Examiner

Tamai IE Karl

Applicant(s)/Patent under
Reexamination

CHOU ET AL.

Art Unit

2834

SEARCHED

Class	Subclass	Date	Examiner
310	309		
73	504.12		
359	291, 298		
385	18	5/30/2005	KIT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR